

## **Description**

The vs6NP03-s8 uses advanced trench technology to provide excellent  $R_{\rm DS(ON)}$  and low gate charge . The complementary MOSFETs may be used to form a level shifted high side switch, and for a host of other applications.

#### **General Features**

#### N-Channel

 $V_{DS} = 30V, I_{D} = 6.5A$ 

 $R_{DS(ON)}$  < 24m $\Omega$  @  $V_{GS}$ =10V

 $R_{DS(ON)}$  < 37m $\Omega$  @  $V_{GS}$ =4.5V

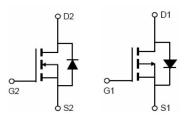
#### P-Channel

 $V_{DS} = -30V, I_{D} = -7A$ 

 $R_{DS(ON)}$  < 37.5m $\Omega$  @  $V_{GS}$ =-10V

 $R_{DS(ON)} < 75 m\Omega$  @  $V_{GS}$ =-4.5V

- High power and current handing capability
- Lead free product is acquired
- Surface mount package



N-channel

P-channel

Schematic diagram



#### Package Marking and Ordering Information

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
VS6NP03-S8	VS6NP03-S8	SOP-8	Ø330mm	12mm	

### Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Parameter		Symbol	N-Channel	P-Channel	Unit	
Drain-Source Voltage		V <sub>DS</sub>	30	-30	V	
Gate-Source Voltage		V <sub>GS</sub>	±20	±20	V	
Continuous Dunin Comment	T <sub>A</sub> =25℃	L	6.5	-7	Α	
Continuous Drain Current	T <sub>A</sub> =70℃	l <sub>D</sub>	5.4	-5.8		
Pulsed Drain Current (Note 1)		I <sub>DM</sub>	30	-30	Α	
Maximum Power Dissipation	T <sub>A</sub> =25℃	P <sub>D</sub>	2.0	2.0	W	
Operating Junction and Storage Temperature Range		T <sub>J</sub> ,T <sub>STG</sub>	-55 To 150	-55 To 150	$^{\circ}$	

## **Thermal Characteristic**

Thermal Resistance,Junction-to-Ambient (Note2)	$R_{\theta JA}$	N-Ch	62.5	°C/W
Thermal Resistance, Junction-to-Ambient (Note2)	R <sub>0JA</sub>	P-Ch	62.5	°C/W



## N-CH Electrical Characteristics (TA=25 $^{\circ}$ C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
Off Characteristics						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =250μA	30	33	3 <b>—</b> 3	V
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =30V,V <sub>GS</sub> =0V	-	-	1	μΑ
Gate-Body Leakage Current	I <sub>GSS</sub>	V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V	-	-	±100	nA
On Characteristics (Note 3)						
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS},I_{D}=250\mu A$	1	1.6	3	V
Dunin Course On State Begintanes		V <sub>GS</sub> =10V, I <sub>D</sub> =6A	-	19	24	mΩ
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =4.5V, I <sub>D</sub> =6A	-	26	37	mΩ
Forward Transconductance	<b>g</b> FS	$V_{DS}$ =5 $V$ , $I_{D}$ =6 $A$	15	-	1-1	S
Dynamic Characteristics (Note4)						
Input Capacitance	C <sub>lss</sub>	\/ -45\/\/ -0\/	-	530.3		PF
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =15V, $V_{GS}$ =0V, F=1.0MHz	-	67.1	-	PF
Reverse Transfer Capacitance	C <sub>rss</sub>	F=1.UIVITIZ	-	61.2	н	PF
Switching Characteristics (Note 4)	,		1			1
Turn-on Delay Time	t <sub>d(on)</sub>		-	4.5	-	nS
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =15V, $R_L$ =2.5 $\Omega$	-	2.5	-	nS
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =10 $V$ , $R_{GEN}$ =3 $\Omega$	-	14.5	x=0	nS
Turn-Off Fall Time	t <sub>f</sub>		=	3.5	-	nS
Total Gate Charge	Qg	\/ -45\/1 -CA	-	14.2	u= :	nC
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}=15V,I_{D}=6A,$	-	1.8	-	nC
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =10V	-	3.3	1-1	nC
Drain-Source Diode Characteristics			,			
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	$V_{GS}$ =0 $V$ , $I_{S}$ =6 $A$	-	0.8	1.2	V



# P-CH Electrical Characteristics ( $T_A$ =25 $^{\circ}$ C unless otherwise noted)

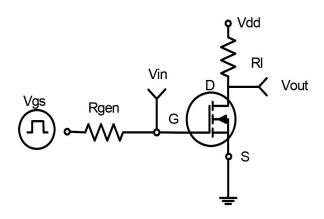
Parameter	Symbol	Condition	Min	Тур	Max	Unit	
Off Characteristics							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-30	-33	-	V	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> =-30V,V <sub>GS</sub> =0V	-	-	-1	μA	
Gate-Body Leakage Current	I <sub>GSS</sub>	I <sub>GSS</sub> V <sub>GS</sub> =±20V,V <sub>DS</sub> =0V		-	±100	nA	
On Characteristics (Note 3)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS}=V_{GS},I_{D}=-250\mu A$	-1.3	-1.65	-2.5	V	
Drain-Source On-State Resistance		V <sub>GS</sub> =-10V, I <sub>D</sub> =-6.5A	-	33	37.5	mΩ	
Diam-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-6.5A	-	52	75	mΩ	
Forward Transconductance	<b>g</b> FS	V <sub>DS</sub> =-5V,I <sub>D</sub> =-6.5A	10	-	-	S	
Dynamic Characteristics (Note4)							
Input Capacitance	C <sub>lss</sub>	\/ - 45\/\/ -0\/	-	729.4	-	PF	
Output Capacitance	C <sub>oss</sub>	$V_{DS}$ =-15V, $V_{GS}$ =0V, F=1.0MHz	-	112.6	-	PF	
Reverse Transfer Capacitance	C <sub>rss</sub>	F-1.UIVITZ	-	107.5	-	PF	
Switching Characteristics (Note 4)							
Turn-on Delay Time	t <sub>d(on)</sub>		-	7.5	-	nS	
Turn-on Rise Time	t <sub>r</sub>	$V_{DD}$ =-15V, $R_L$ =2.3 $\Omega$	-	5.5	-	nS	
Turn-Off Delay Time	t <sub>d(off)</sub>	$V_{GS}$ =-10 $V$ , $R_{GEN}$ =6 $\Omega$	-	19	-	nS	
Turn-Off Fall Time	t <sub>f</sub>		=	7	-	nS	
Total Gate Charge	Qg	\/ - 45\/ L - C.5A	-	16.6	-	nC	
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS}$ =-15V, $I_{D}$ =-6.5A	-	1.8	-	nC	
Gate-Drain Charge	Q <sub>gd</sub>	V <sub>GS</sub> =-10V	-	4.2	-	nC	
Drain-Source Diode Characteristics							
Diode Forward Voltage (Note 3)	V <sub>SD</sub>	V <sub>GS</sub> =0V,I <sub>S</sub> =-6.5A	-	-	-1.2	V	

#### Notes:

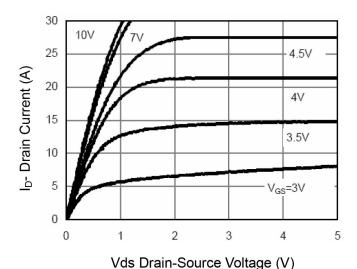
- 1. Repetitive Rating: Pulse width limited by maximum junction temperature.
- **2.** Surface Mounted on FR4 Board,  $t \le 10$  sec.
- 3. Pulse Test: Pulse Width  $\leq$  300 $\mu$ s, Duty Cycle  $\leq$  2%.
- 4. Guaranteed by design, not subject to production



## N- Channel Typical Electrical and Thermal Characteristics (Curves)



**Figure 1:Switching Test Circuit** 



**Figure 3 Output Characteristics** 

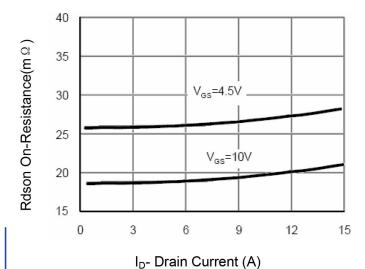
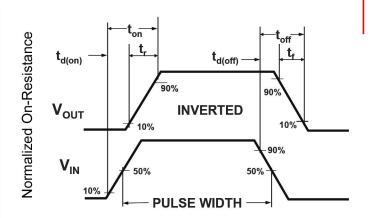


Figure 5 Drain-Source On-Resistance



**Figure 2:Switching Waveforms** 

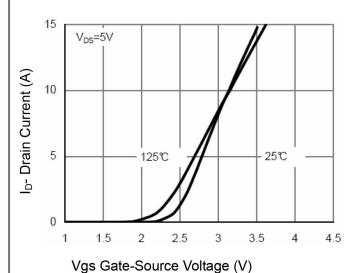


Figure 4 Transfer Characteristics

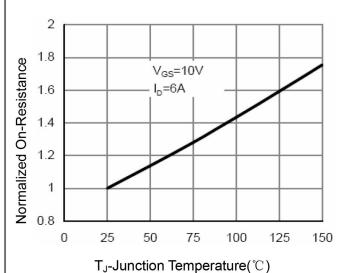


Figure 6 Drain-Source On-Resistance

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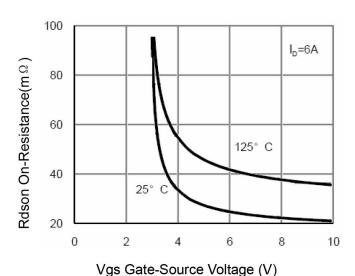
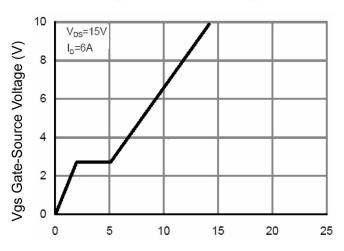
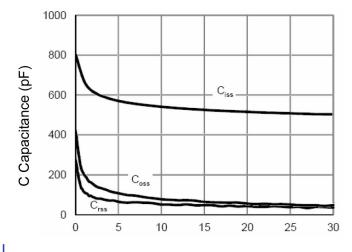


Figure7 Rdson vs Vgs

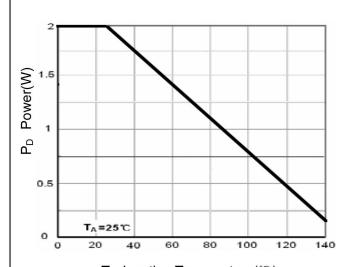


Qg Gate Charge (nC) Figure 9 Gate Charge



Vds Drain-Source Voltage (V)

Figure 11 Capacitance vs Vds



T<sub>J</sub>-Junction Temperature(°C) Figure 8 Power Dissipation

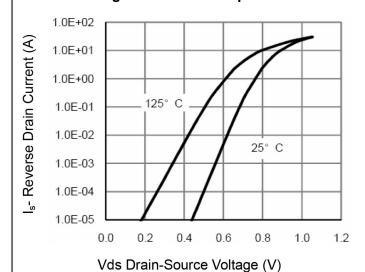
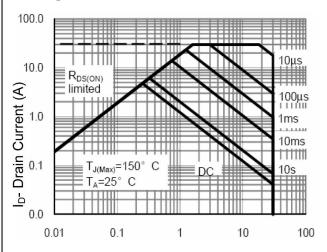


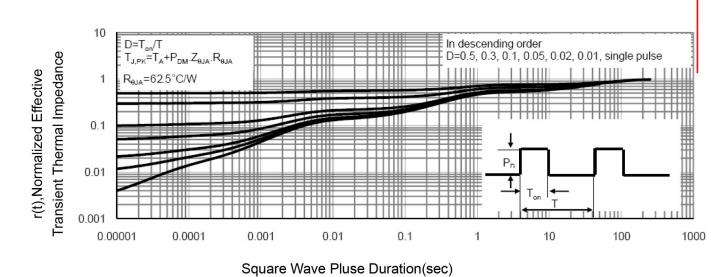
Figure 10 Source- Drain Diode Forward



Vds Drain-Source Voltage (V)

Figure 12 Safe Operation Area

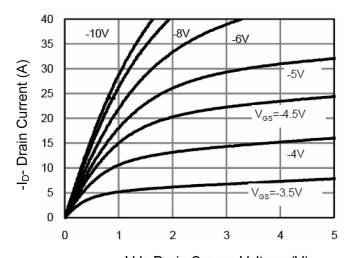




**Figure 13 Normalized Maximum Transient Thermal Impedance** 

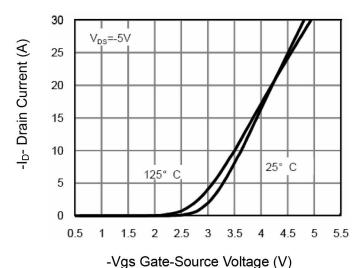


## P- Channel Typical Electrical and Thermal Characteristics (Curves)



-Vds Drain-Source Voltage (V)

Figure 1 Output Characteristics



**Figure 2 Transfer Characteristics** 

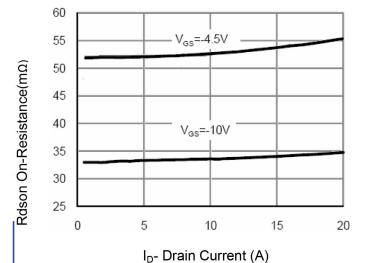
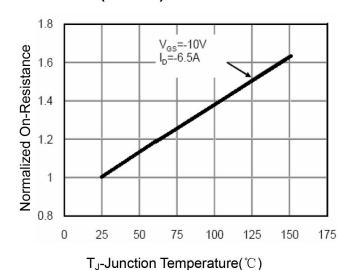


Figure 3 Rdson- Drain Current



**Figure 4 Rdson-Junction Temperature** 

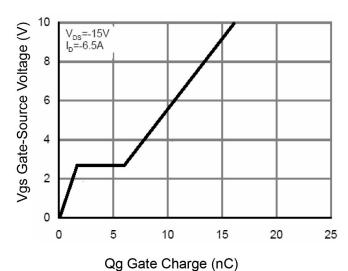


Figure 5 Gate Charge

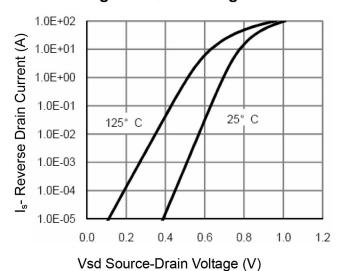


Figure 6 Source- Drain Diode Forward

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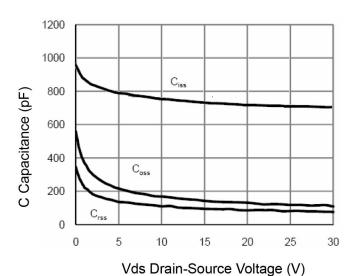
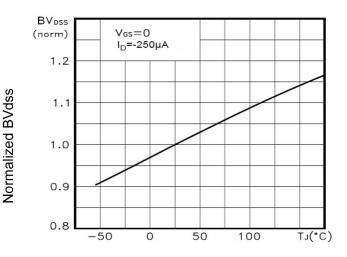


Figure 7 Capacitance vs Vds



 $T_J$ -Junction Temperature (°C) Figure 9 BV<sub>DSS</sub> vs Junction Temperature

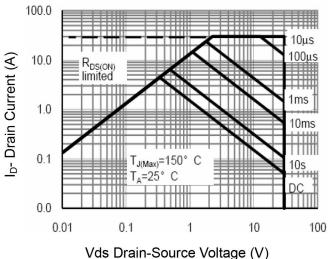


Figure 8 Safe Operation Area

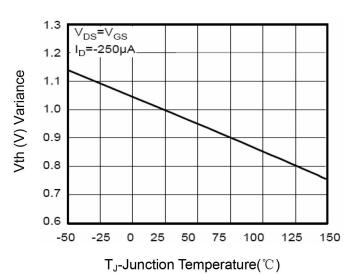
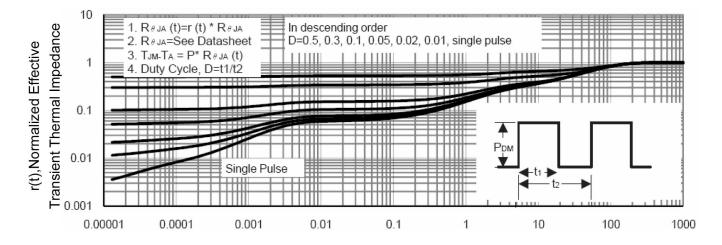


Figure 10 V<sub>GS(th)</sub> vs Junction Temperature



Square Wave Pluse Duration(sec)

**Figure 11 Normalized Maximum Transient Thermal Impedance**